Pch -12V -6A Middle Power MOSFET

V_{DSS}	-12V
R _{DS(on)} (Max.)	23mΩ
I _D	±6A
P _D	1.5W

Features

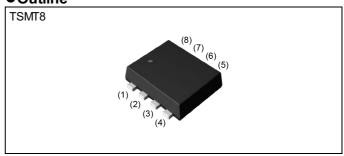
- 1) Low on resistance.
- 2) -1.5V Drive
- 3) Built-in G-S protection diode.
- 4) Small surface mount package(TSMT8).
- 5) Pb-free lead plating; RoHS compliant

Application

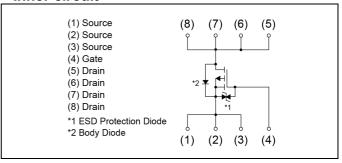
Switching

	Marking		111				
●Absolute maximum ratings (T _a = 25°C)							
Parameter	Symbol	Value	Unit				
Drain - Source voltage	V _{DSS}	-12	V				
Continuous drain current	I _D	±6	Α				
Pulsed drain current	I _{D,pulse} *1	±24	Α				
Gate - Source voltage	V _{GSS}	±10	V				
Davier discipation	P _D *2	1.5	W				
Power dissipation	P _D *3	0.7	W				
Junction temperature	T _j	150	°C				
Range of storage temperature	T _{stg}	-55 to +150	°C				

Outline



Inner circuit



Packaging specifications

	Packing	Embossed Tape
	Reel size (mm)	180
Туре	Tape width (mm)	8
	Basic ordering unit (pcs)	3000
	Taping code	TR
	Marking	ΥH

●Thermal resistance

Downston	Cymhol	Values			Linit
Parameter	Symbol	Min.	Тур.	Max.	Unit
Thermal registeres innetion, ambient	R _{thJA} *2	-	-	83.3	°C/W
Thermal resistance, junction - ambient	R _{thJA} *3	-	-	178	°C/W

● Electrical characteristics (T_a = 25°C)

Doromotor	Symbol Conditions		Values			Unit
Parameter			Min.	Тур.	Max.	Offic
Drain - Source breakdown voltage	V _{(BR)DSS}	$V_{GS} = 0V$, $I_D = -1mA$	-12	-	-	V
Breakdown voltage temperature coefficient	$\frac{\Delta V_{(BR)DSS}}{\Delta T_{j}}$	I _D = -1mA referenced to 25°C	-	-21.9	-	mV/°C
Zero gate voltage drain current	I _{DSS}	V _{DS} = -12V, V _{GS} = 0V	-	-	-1	μA
Gate - Source leakage current	I _{GSS}	$V_{GS} = \pm 10V, V_{DS} = 0V$	-	1	±10	μA
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = -6V, I_{D} = -1mA$	-0.3	1	-1.0	V
Gate threshold voltage temperature coefficient	$\frac{\Delta V_{GS(th)}}{\Delta T_{j}}$	I _D = -1mA referenced to 25°C	-	2.4	-	mV/°C
		V _{GS} = -4.5V, I _D = -6A	-	16	23	
Static drain - source	R _{DS(on)} *4	V _{GS} = -2.5V, I _D = -3A	-	22	31	0
on - state resistance		$V_{GS} = -1.8V, I_D = -3A$	-	28	42	mΩ
		V _{GS} = -1.5V, I _D = -1.2A	-	39	78	
Gate input resistance	R_G	f = 1MHz, open drain	-	20	1	Ω
Forward Transfer Admittance	Y _{fs} *4	$V_{DS} = -6V, I_{D} = -6A$	7.5	-	-	S

^{*1} Pw≦10µs , Duty cycle≦1%

^{*2} Mounted on a ceramic board (30×30×0.8mm)

^{*3} Mounted on a FR4 (20×20×0.8mm)

^{*4} Pulsed

● Electrical characteristics (T_a = 25°C)

Parameter	Symbol	Conditions	Values			Lloit	
	Symbol Conditions —		Min.	Тур.	Max.	Unit	
Input capacitance	C _{iss}	V _{GS} = 0V	1	2800	1		
Output capacitance	C _{oss}	V _{DS} = -6V	1	340	1	pF	
Reverse transfer capacitance	C _{rss}	f = 1MHz	1	310	1		
Turn - on delay time	t _{d(on)} *4	$V_{DD} \simeq -6V, V_{GS} = -4.5V$	1	12	1		
Rise time	t _r *4	I _D = -3A	-	105	-	no	
Turn - off delay time	t _{d(off)} *4	$R_L \simeq 2\Omega$		400	1	ns	
Fall time	t _f *4	$R_G = 10\Omega$	-	230	1		

● Gate charge characteristics (T_a = 25°C)

Parameter	Symbol Conditions -	Conditions	Values			Unit
		Min.	Тур.	Max.	Offic	
Total gate charge	Qg*4	V _{DD} ≃ -6V,	1	34	1	
Gate - Source charge	Q _{gs} *4	I _D = -6A, V _{GS} = -4.5V	-	6.0	-	nC
Gate - Drain charge	Q _{gd} *4	V _{GS} = -4.5V	-	5.0	-	

●Body diode electrical characteristics (Source-Drain) (T_a = 25°C)

Parameter	Symbol	Conditions	Values			Unit
			Min.	Тур.	Max.	Offic
Body diode continuous forward current	I _S	T 05°0	-	1	-1	А
Body diode pulse current	I _{SP} *1	T _a = 25°C	-	-	-24	Α
Forward voltage	V _{SD} *4	$V_{GS} = 0V, I_{S} = -6A$	-	-	-1.2	V

Fig.1 Power Dissipation Derating Curve

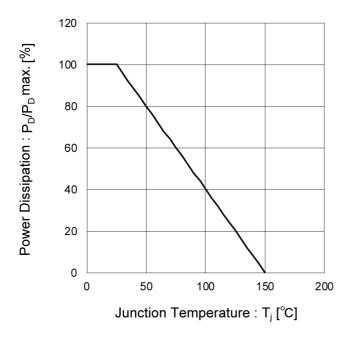


Fig.2 Maximum Safe Operating Area

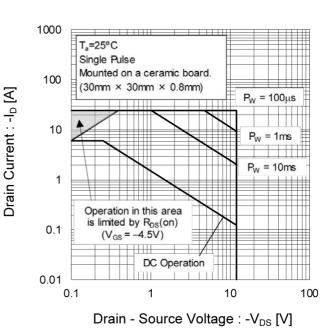


Fig.3 Normalized Transient Thermal Resistance vs. Pulse Width

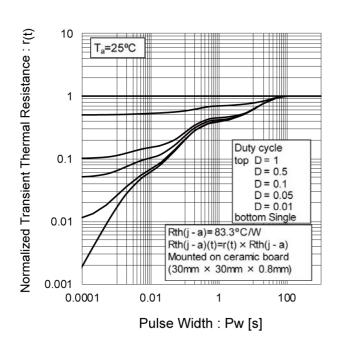


Fig.4 Single Pulse Maximum Power dissipation

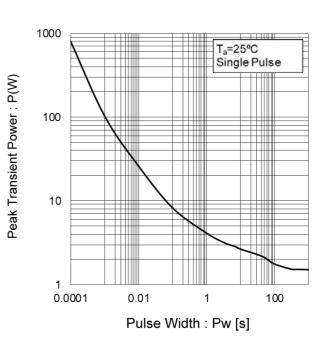


Fig.5 Typical Output Characteristics(I)

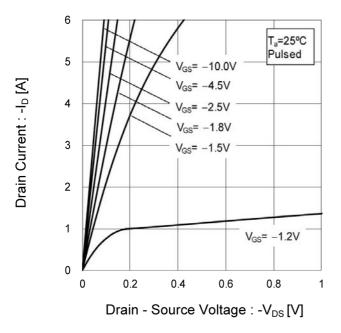


Fig.6 Typical Output Characteristics(II)

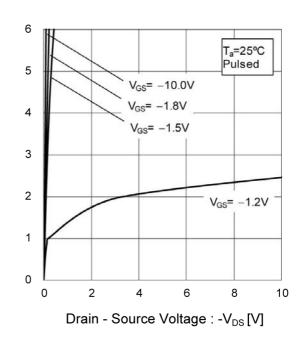


Fig.7 Breakdown Voltage vs.
Junction Temperature

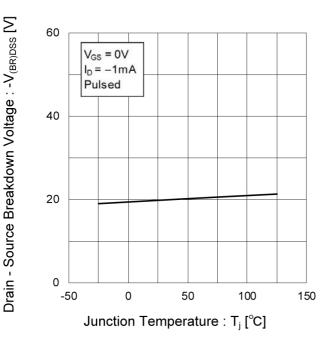
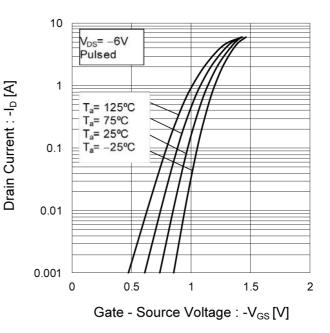


Fig.8 Typical Transfer Characteristics



Drain Current : -I_D [A]

Gate Threshold Voltage: -V_{GS(th)} [V]

• Electrical characteristic curves

Fig.9 Gate Threshold Voltage vs.
Junction Temperature

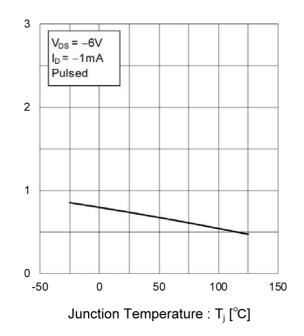


Fig.10 Forward Transfer Admittance vs.
Drain Current

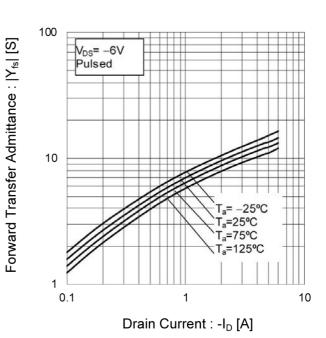


Fig.11 Drain Current Derating Curve

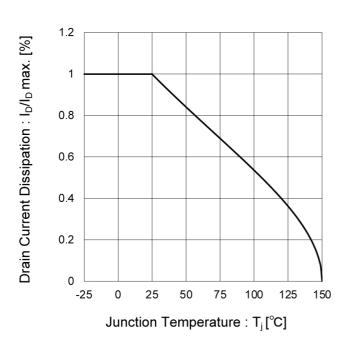


Fig.12 Static Drain - Source On - State Resistance vs. Gate Source Voltage

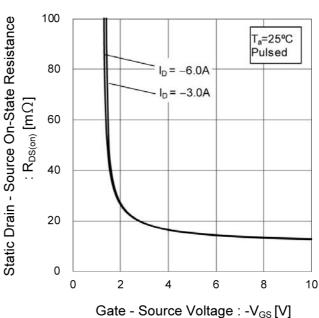
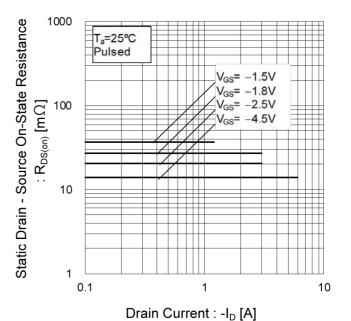


Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature

30 Static Drain - Source On-State Resistance 25 20 $: R_{DS(on)} [m\Omega]$ 15 10 $V_{GS} = -4.5V$ $I_{D} = -6.0A$ Pulsed 25 -25 50 100 125 150 -50 Junction Temperature : T_i [°C]

Fig.14 Static Drain - Source On - State Resistance vs. Drain Current (I)



ROHM

Fig.15 Static Drain - Source On - State Resistance vs. Drain Current (II)

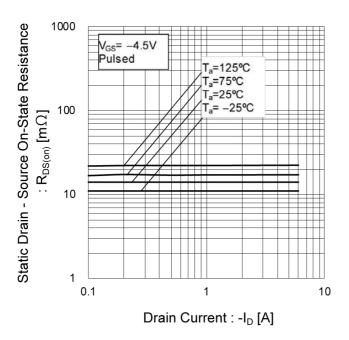


Fig.16 Static Drain - Source On - State
Resistance vs. Drain Current (III)

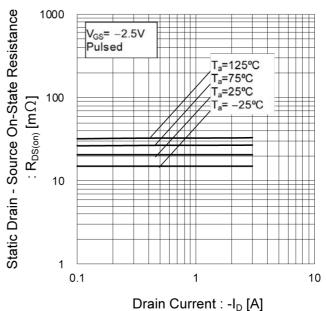


Fig.17 Static Drain - Source On - State Resistance vs. Drain Current (IV)

1000 Static Drain - Source On-State Resistance V_{GS}= -1.8V :125°C Pulsed =75°C =25°C -25°C 100 $R_{\text{DS(on)}} \, [\text{m}\Omega]$ 10 1 0.1 1 10 Drain Current: -ID [A]

Fig.18 Static Drain - Source On - State Resistance vs. Drain Current (V)

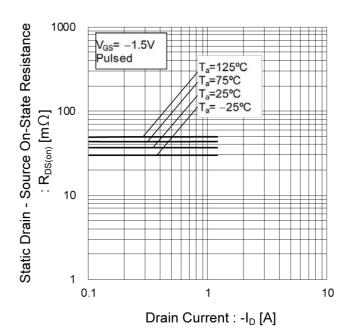


Fig.19 Typical Capacitance vs.

Drain - Source Voltage

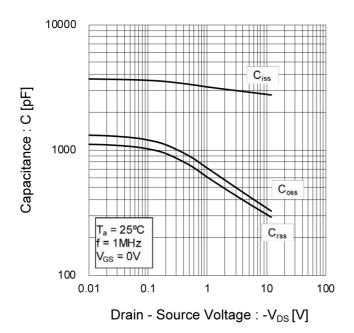


Fig.20 Switching Characteristics

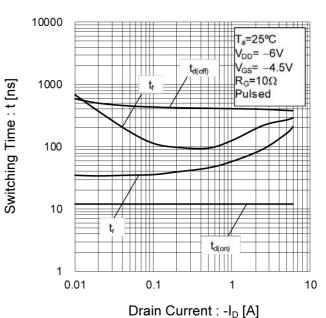


Fig.21 Dynamic Input Characteristics

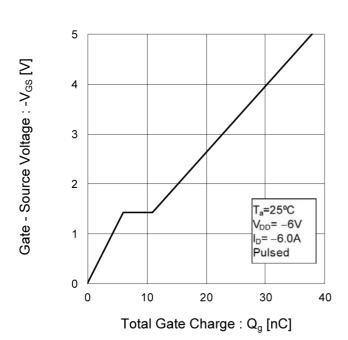
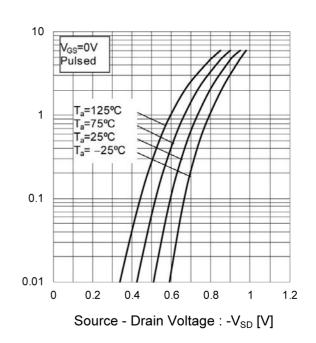


Fig.22 Source Current vs.

Source Drain Voltage



Source Current : -I_s [A]

Measurement circuits

Fig. 1-1 SWITCHING TIME MEASUREMENT CIRCUIT

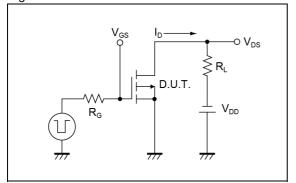


Fig. 2-1 GATE CHARGE MEASUREMENT CIRCUIT

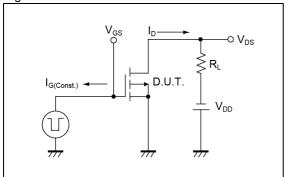


Fig. 1-2 SWITCHING WAVEFORMS

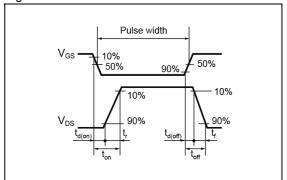
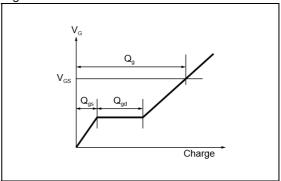


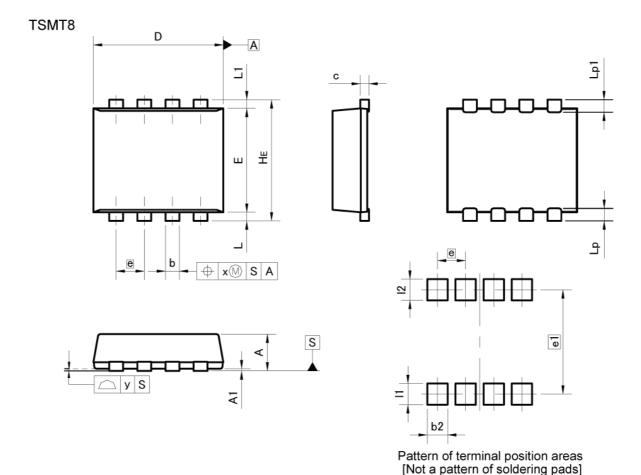
Fig. 2-2 GATE CHARGE WAVEFORM



Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

Dimensions



MILIMETERS INCHES DIM MIN MAX MIN MAX A 0.75 0.85 0.030 0.033 A1 0.00 0.05 0.000 0.002 b 0.27 0.37 0.011 0.015 C 0.12 0.22 0.005 0.009 D 2.90 3.10 0.114 0.122 2.30 2.50 0.091 0.098 Е 0.026 0.65 е 0.114 2.70 2.90 0.106 HE 0.10 0.30 0.004 0.012 L L1 0.10 0.30 0.004 0.012 Lp 0.19 0.39 0.007 0.015 0.19 0.39 0.007 0.015 Lp1 0.10 0.004

DIM	MILIMETERS		INC	HES
DIM L	MIN	MAX	MIN	MAX
b2	244	0.47	-	0.019
e1	2.41		0.095	
11	-	0.49	-	0.019
12	8. 	0.49	_	0.019

0.10

Dimension in mm/inches



0.004

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